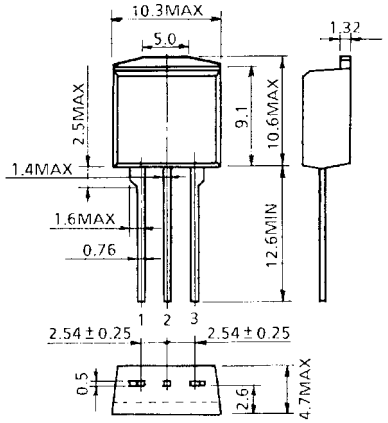
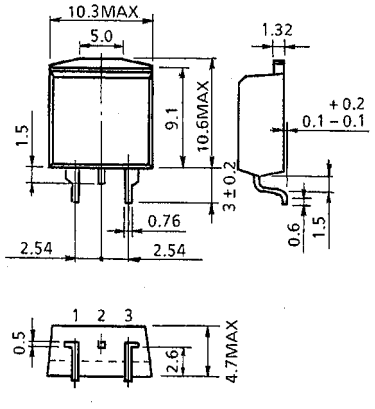
TOSHIBA THYRISTOR SILICON PLANAR TYPE

SF10G48,SF10J48,USF10G48,USF10J48

MEDIUM POWER CONTROL APPLICATIONS

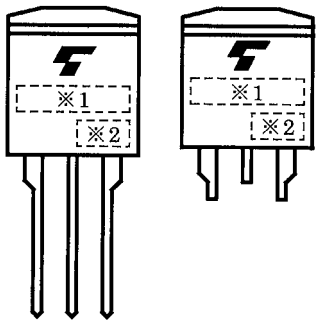
- Repetitive Peak Off−State Voltage : V_{DRM} = 400,600V
- Repetitive Peak Reverse Voltage : V_{RRM} = 400,600V
- Average On−State Current : $I_{T\ (AV)}$ = 10A
- Gate Trigger Current : I_{GT} = 10mA MAX.

Unit: mm

SF10G48·SF10J48		USF10G48·USF10J48	
 1. CATHODE 2. ANODE 3. GATE		 1. CATHODE 2. ANODE (BACK SIDE) 3. GATE	
JEDEC	—	JEDEC	—
JEITA	—	JEITA	—
TOSHIBA	13−10J1B	TOSHIBA	13−10J2B

Weight: 1.7g

MARKING



*1	MARK	F10G48	TYPE NAME	SF10G48, USF10G48
		F10J48		ASF10J48, USF10J48
*2	Lot Number □ □ ←Month (Starting from Alphabet A) Year (Last Decimal Digit of the Current Year)			

MAXIMUM RATINGS

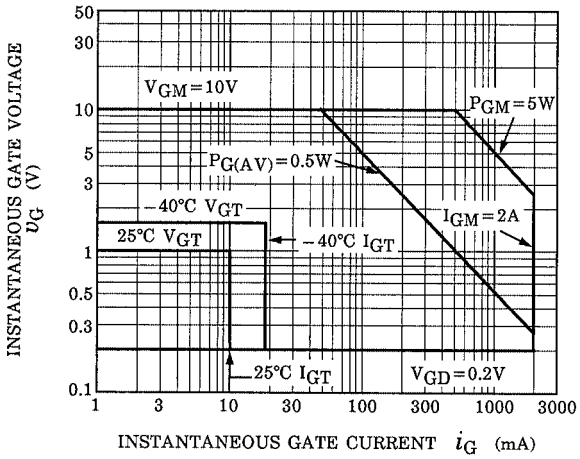
CHARACTERISTIC		SYMBOL	RATING	UNIT
Repetitive Peak Off−State Voltage and Repetitive Peak Reverse Voltage	SF10G48 USF10G48	V_{DRM} V_{RRM}	400	V
	SF10J48 USF10J48		600	
Non−Repetitive Peak Reverse Voltage (Non−Repetitive <5ms, T_j = 0~125°C)	SF10G48 USF10G48	V_{RSM}	500	V
	SF10J48 USF10J48		720	
Average On−State Current		$I_{T\ (AV)}$	10	A
R.M.S On−State Current		$I_{T\ (RMS)}$	16	A
Peak One Cycle Surge On−State Current (Non-Repetitive)		I_{TSM}	160 (50Hz)	A
			176 (60Hz)	
I^2t Limit Value		I^2t	125	A^2s
Critical Rate of Rise of On−State Current (Note 1)		di / dt	100	A / μs
Peak Gate Power Dissipation		P_{GM}	5	W
Average Gate Power Dissipation		$P_{G\ (AV)}$	0.5	W
Peak Forward Gate Voltage		V_{FGM}	10	V
Peak Reverse Gate Voltage		V_{RGM}	−5	V
Peak Forward Gate Current		I_{GM}	2	A
Junction Temperature		T_j	−40~125	°C
Storage Temperature Range		T_{stg}	−40~125	°C

Note 1: V_{DRM} = 0.5 × Rated, I_{TM} ≤ 30A, t_{gw} ≥ 10μs, t_{gr} ≤ 250ns, $i_{gp} = I_{GT} \times 2.0$

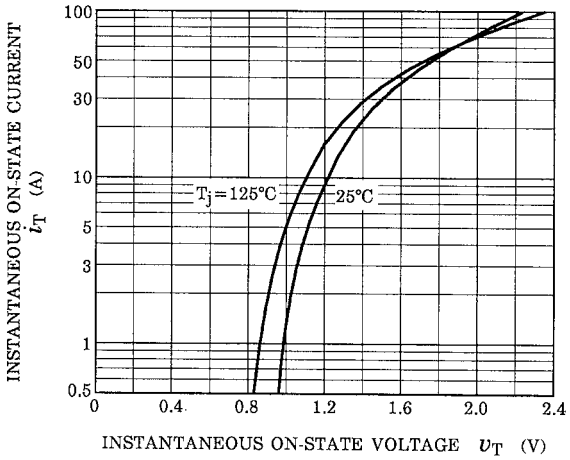
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Repetitive Peak Off−State Current and Repetitive Peak Reverse Current	I_{DRM} I_{RRM}	$V_{DRM} = V_{RRM}$ = Rated	—	—	10	μA
Peak On−State Voltage	V_{TM}	I_{TM} = 30A	—		1.5	V
Gate Trigger Voltage	V_{GT}	V_D = 6V, R_L = 10Ω	—	—	1.0	V
Gate Trigger Current	I_{GT}		—	—	10	mA
Gate Non−Trigger Voltage	V_{GD}	V_D = Rated × 2 / 3, Tc = 125°C	0.2	—	—	V
Critical Rate of Rise of Off−State Voltage	dv /dt	V_{DRM} = Rated, Tc = 125°C Exponential Rise	—	50	—	V / μs
Holding Current	I_H	V_D = 6V, I_{TM} = 1A	—	—	40	mA
Latching Current	I_L	V_D = 6V, f = 50Hz t_{gw} = 50μs, i_G = 30mA	—	—	50	mA
Thermal Resistance	$R_{th\ (j-c)}$	Junction to Case, DC	—	—	2.5	°C / W

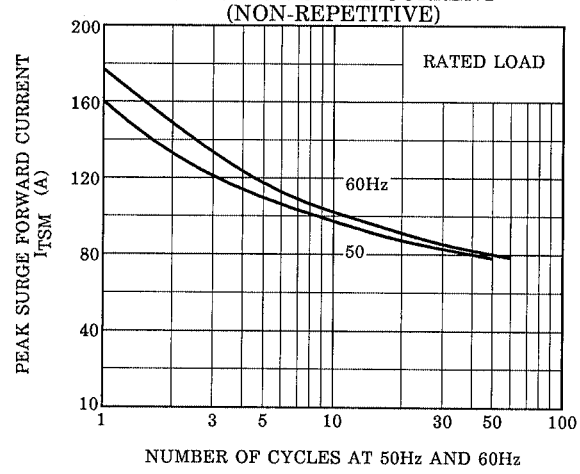
GATE TRIGGER CHARACTERISTIC



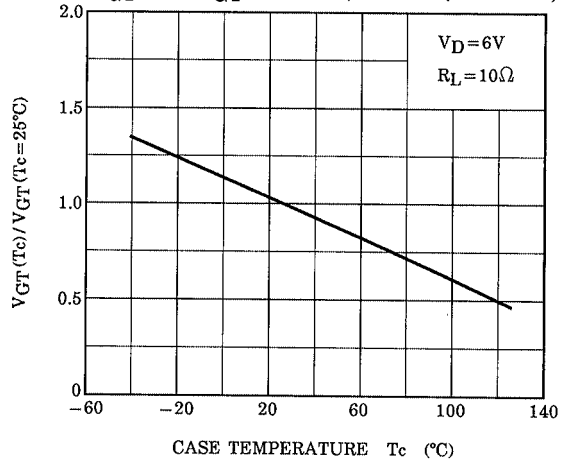
$i_T - v_T$



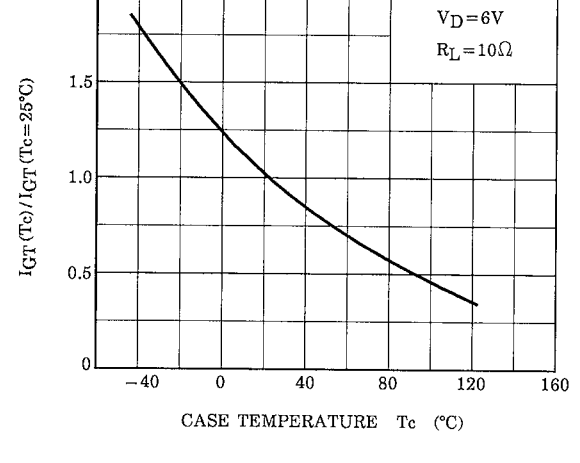
SURGE ON-STATE CURRENT
(NON-REPETITIVE)



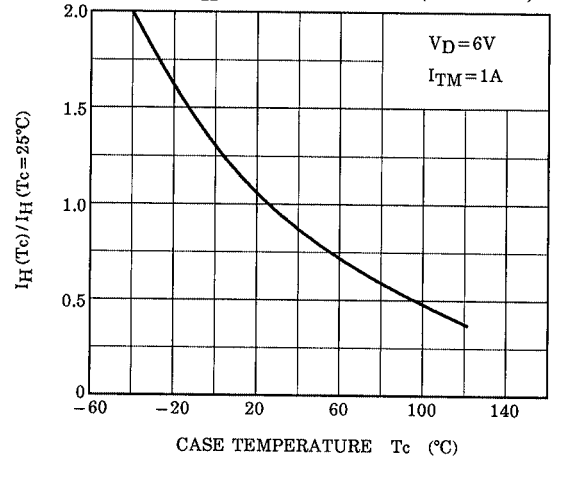
V_{GT} (Tc) / V_{GT} (Tc=25°C) − Tc (TYPICAL)



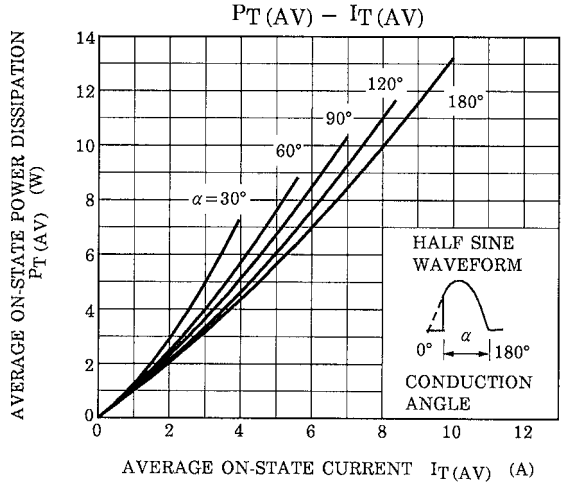
I_{GT} (Tc) / I_{GT} (Tc=25°C) − Tc (TYPICAL)



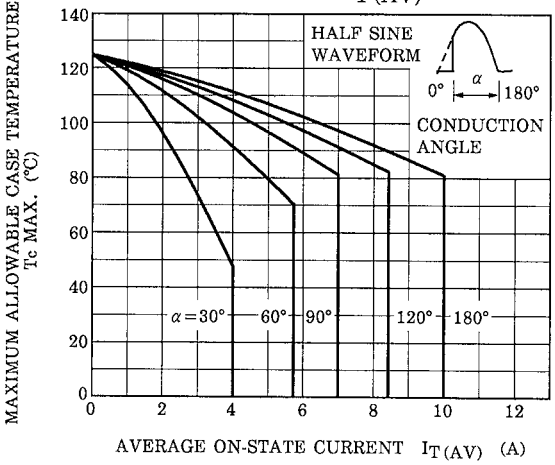
I_H (Tc) / I_H (Tc=25°C) − Tc (TYPICAL)



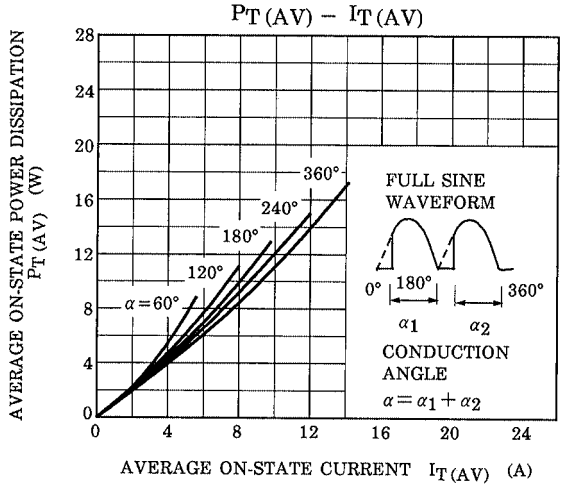
$P_{T(AV)} - I_{T(AV)}$



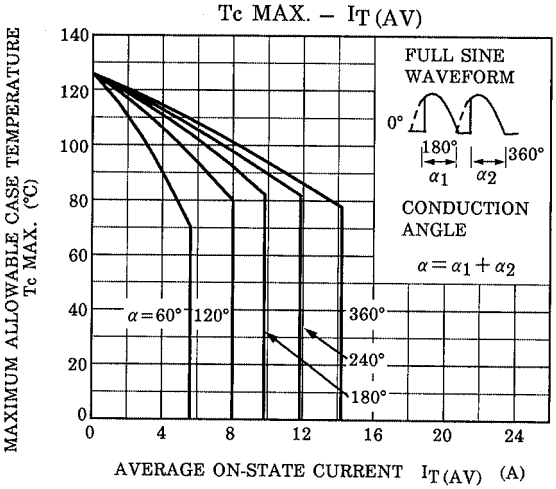
T_c MAX. – $I_{T(AV)}$



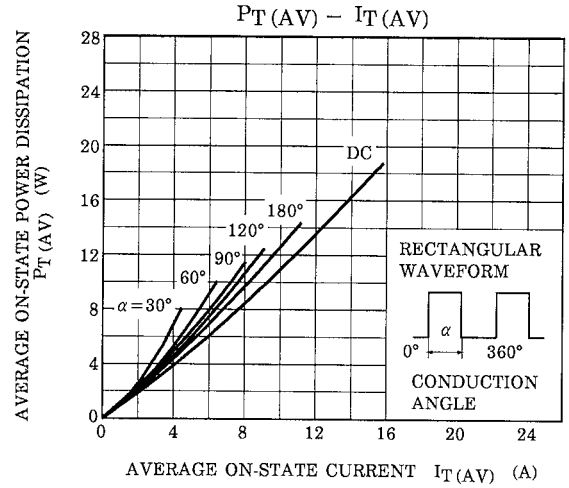
$P_{T(AV)} - I_{T(AV)}$



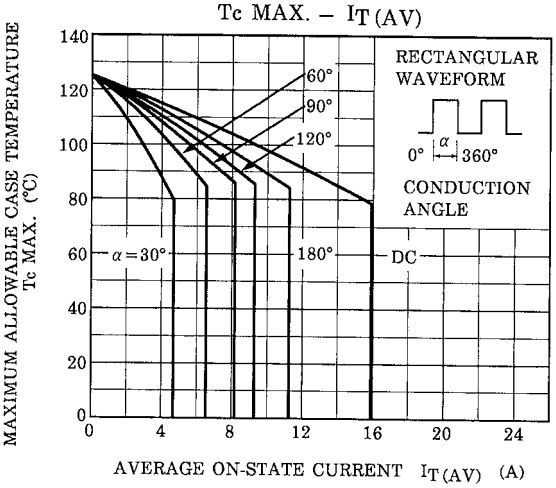
T_c MAX. – $I_{T(AV)}$



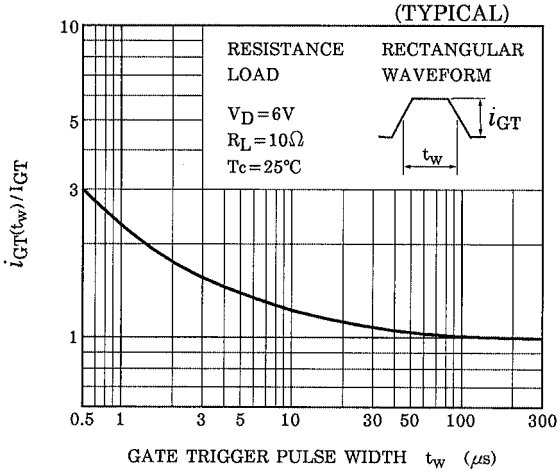
$P_{T(AV)} - I_{T(AV)}$



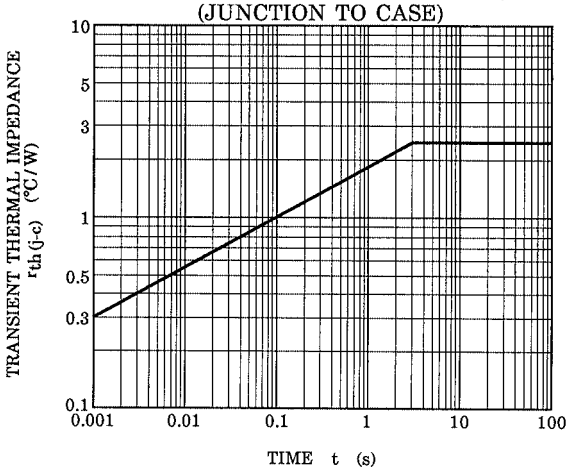
T_c MAX. – $I_{T(AV)}$



PULSE TRIGGER CHARACTERISTIC
(TYPICAL)



TRANSIENT THERMAL IMPEDANCE
(JUNCTION TO CASE)



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